

2N5401

Amplifier Transistor • Collector-Emitter Voltage: V_{CEO}= 150V • Collector Dissipation: P_C (max)=625mW

- Suffix "-C" means Conter Collector (1. Emitter 2. Collector 3. Base)



1. Emitter 2. Base 3. Collector

PNP Epitaxial Silicon Transistor

Absolute Maximum Ratings T_a=25°C unless otherwise noted

Symbol	Parameter	Value	Units	
V _{CBO}	Collector-Base Voltage	-160	V	
V _{CEO}	Collector-Emitter Voltage	-150	V	
V _{EBO}	Emitter-Base Voltage	-5	V	
I _C	Collector Current	-600	mA	
P _C	Collector Dissipation	625	mW	
TJ	Junction Temperature	150	°C	
T _{STG}	Storage Temperature	-55 ~ 150	°C	

Electrical Characteristics T_a=25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
BV _{CBO}	Collector-Base Breakdown Voltage	$I_C = -100 \mu A, I_E = 0$	-160			V
BV _{CEO}	* Collector-Emitter Breakdown Voltage	$I_C = -1 \text{mA}, I_B = 0$	-150			V
BV _{EBO}	Emitter-Base Breakdown Voltage	$I_E = -10\mu A, I_C = 0$	-5			V
I _{CBO}	Collector Cut-off Current	V _{CB} = -120V, I _E =0			-50	nA
I _{EBO}	Emitter Cut-off Current	V_{EB} = -3V, I_{C} =0			-50	nA
h _{FE}	* DC Current Gain	I _C = -1mA, V _{CE} = -5V I _C = -10mA, V _{CE} = -5V I _C = -50mA, V _{CE} = -5V	30 60 50		240	
V _{CE} (sat)	* Collector-Emitter Saturation Voltage	I_C = -10mA, I_B = -1mA I_C = -50mA, I_B = -5mA			-0.2 -0.5	V V
V _{BE} (sat)	* Base-Emitter Saturation Voltage	I_C = -10mA, I_B = -1mA I_C = -50mA, I_B = -5mA			-1 -1	V V
f _T	Current Gain Bandwidth Product	I _C = -10mA, V _{CE} = -10V, f=100MHz	100		400	MHz
C _{ob}	Output Capacitance	V _{CB} = -10V, I _E =0, f=1MHz			6	pF
N _F	Noise Figure	I_C = -250μA, V_{CE} = -5V R_S =1K Ω f=10Hz to 15.7KHz			8	dB

^{*} Pulse Test: Pulse Width≤300μs, Duty Cycle≤2%

Typical Characteristics

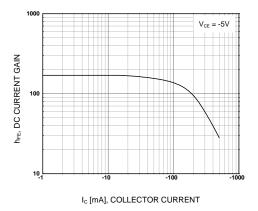


Figure 1. DC current Gain

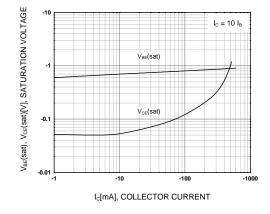


Figure 2. Base-Emitter Saturation Voltage Collector-Emitter Saturation Voltage

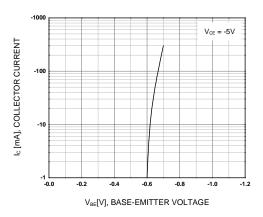


Figure 3. Base-Emitter On Voltage

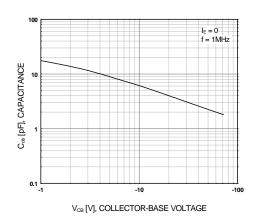


Figure 4. Output Capacitance

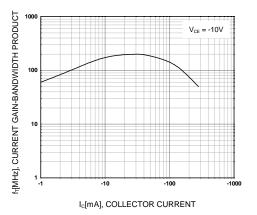
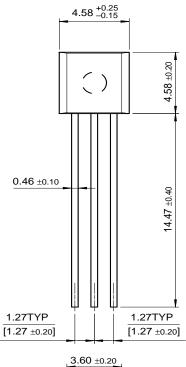


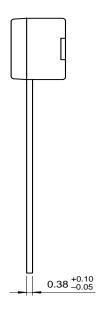
Figure 5. Current Gain Bandwidth Product

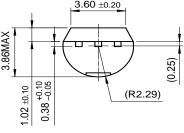
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Package Dimensions

TO-92







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